

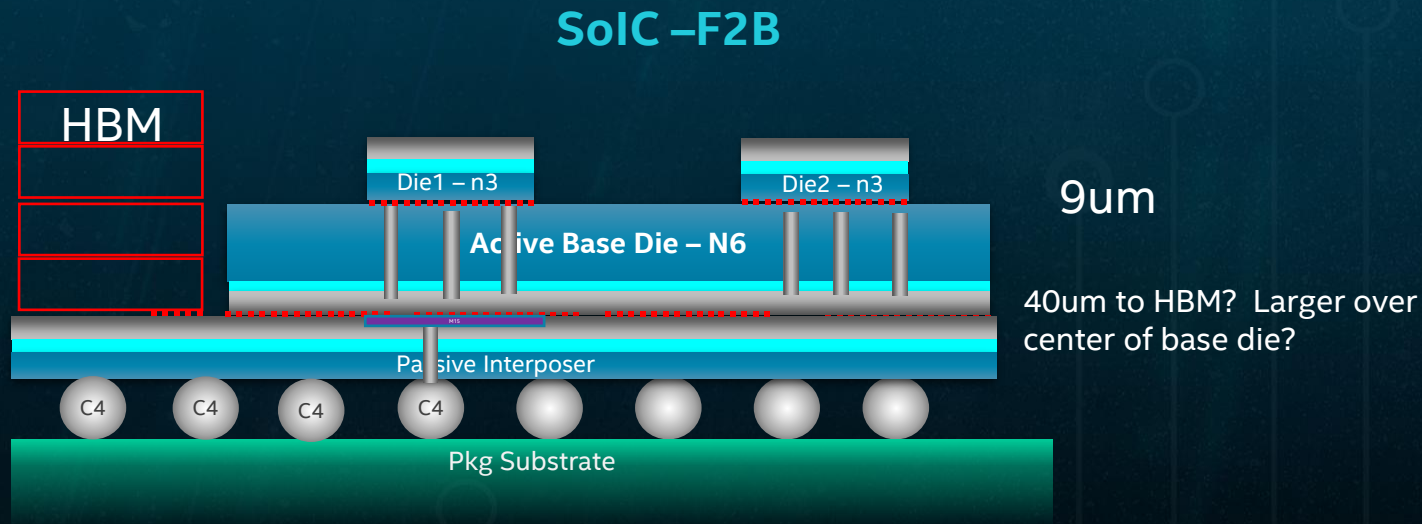
CLIENT GRAPHICS ENGINEERING

# TSMC/INTEL SOIC BRAINSTORM

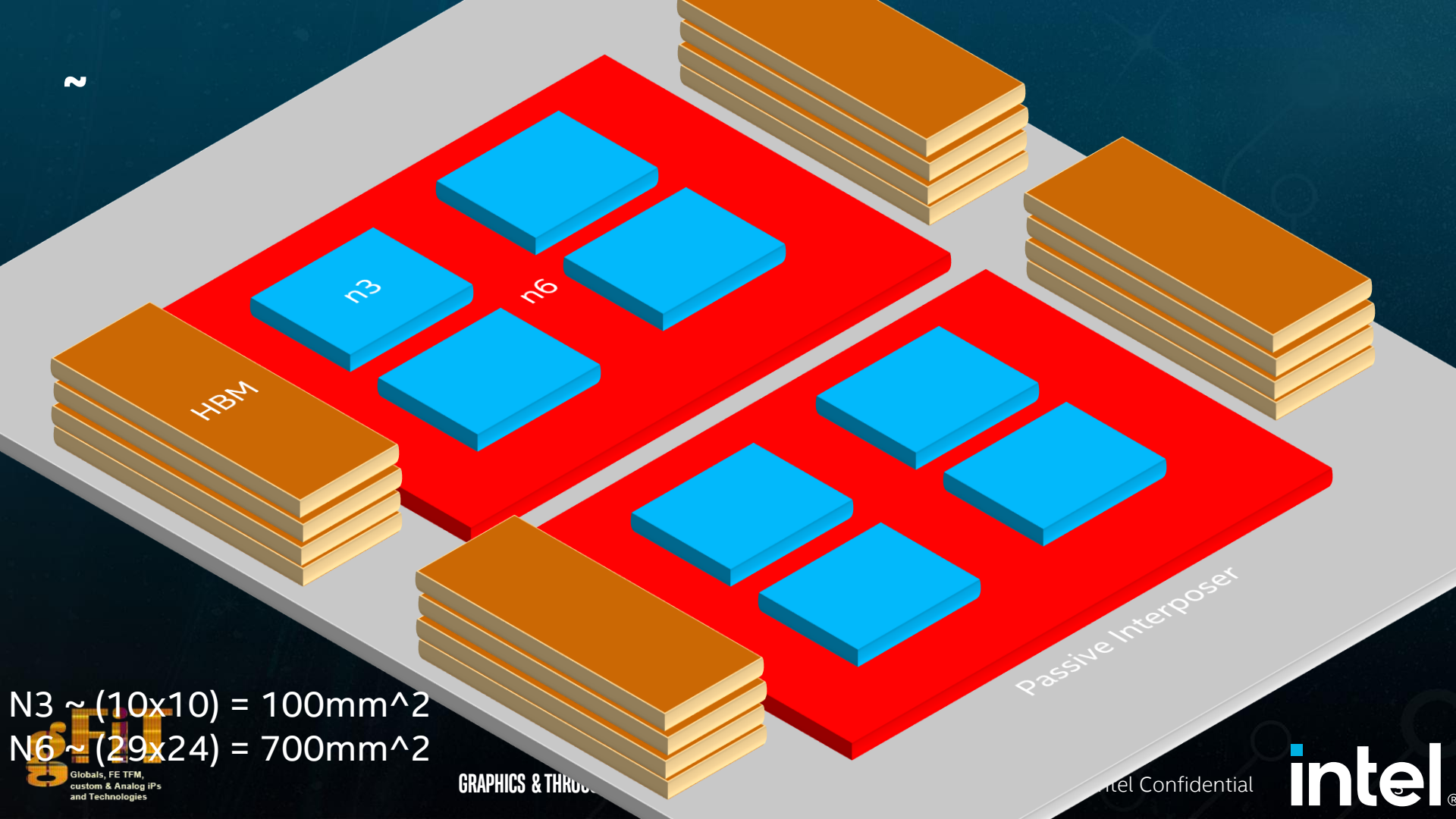
Satish D., Scott S



# PROPOSAL CARTOON







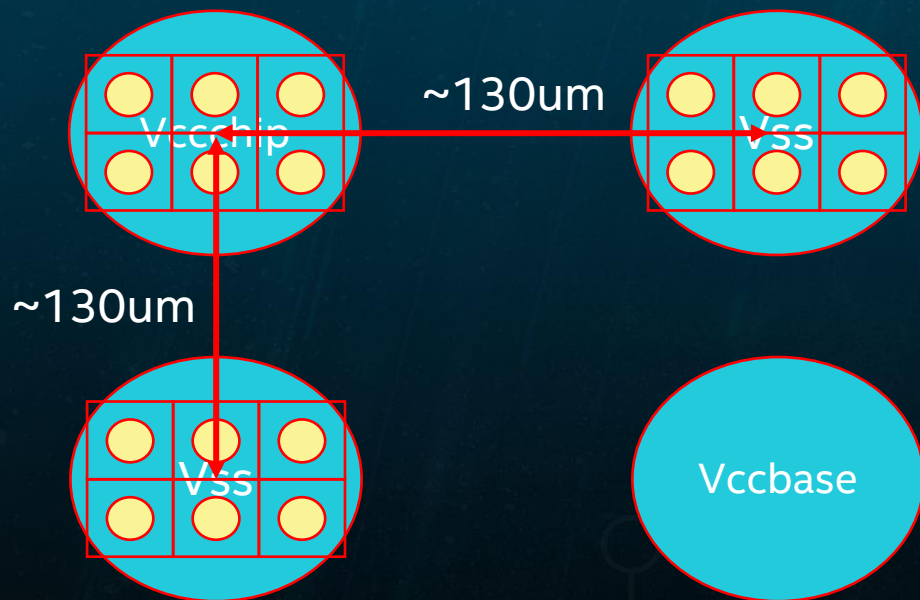
$$N3 \sim (10 \times 10) = 100 \text{mm}^2$$
$$N6 \sim (29 \times 24) = 700 \text{mm}^2$$

GRAPHICS &amp; THROUGH

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# POTENTIAL POWER CONNECTION USING F2B



- Put power TSV farm over C4 bump @  $130 \times 130\mu m$  pitches. No TSVs needed over  $V_{ccbase}$  C4s

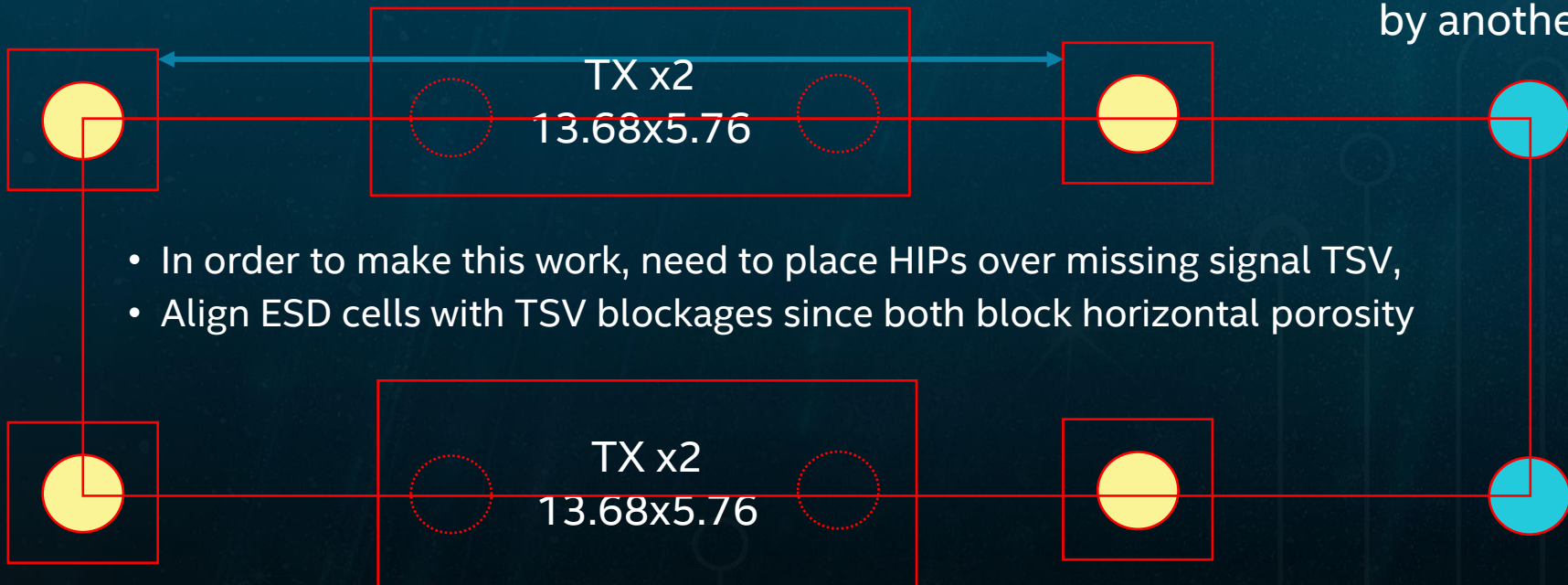
# MEETING THE DENSITY METRIC

- Proposed power TSV – Align a group to the C4 bump to punch through to the top die.
  - Propose a 3x2 array of TSV over top die power C4 bump plus miscellaneous power going to the top die.
- For a 100mm die(10x10) with 130um pitch C4, 77x77 C4 bump grid
  - 5929 C4's
    - 3000 VSS
    - 750 base Vcc(no TSVs required), 2250 Top die Vcc+misc powers
    - 5250 TSV groups \* 6 TSV/C4 = 31,500 TSVs
    - 215k signal TSVs
    - $\sim 2^4 = 46.5k * 4\mu m^2 / TSV = 986k \mu m^2$  or  $0.986mm^2$
    - Estimate about 1% total TSV density across the die for PDN only.
    - Allows up to 1% additional opportunistic TSV placement for improved PDN in areas with no signal, and 1% additional for signal in area of signal.

# POTENTIAL HIP CONNECTION USING F2B

22um between KO zone

Blue bumps driven  
by another Tx

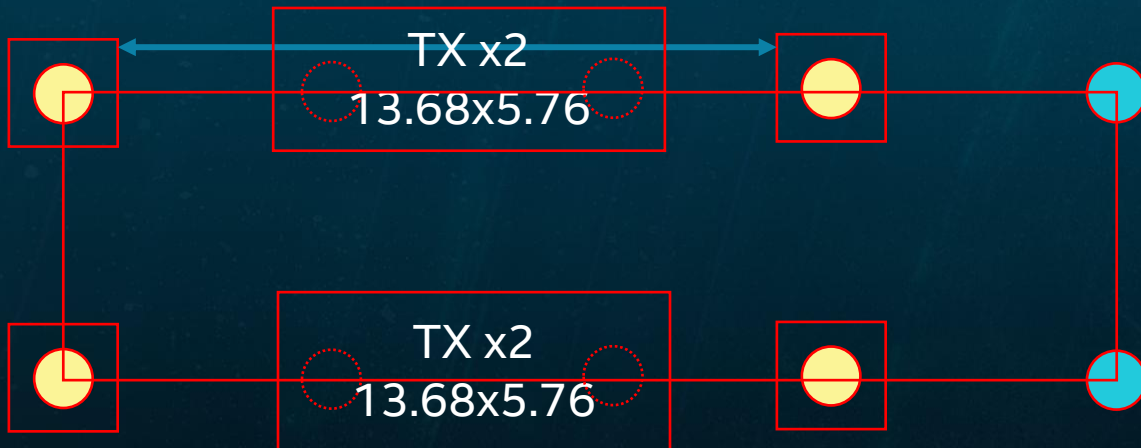


36um between Hybrid Bond buffers (50% depopulation in X, none in Y)



# POTENTIAL HIP CONNECTION USING F2B

22um between KO zone



- $36\mu\text{m} * 9\mu\text{m}$  section.  $= 324 \mu\text{m}^2$ .  $2 \text{ full TSV's} * 3.14\mu\text{m}^2 = 6.28\mu\text{m}^2$
- $6.28/324 = \sim 1.94\%$  - Just under max density of 2% -
  - And we had  $\sim 1\%$  for power – TSV density looks to limit area for Hybrid Bond pads
  - $45\mu\text{m} = 1.55\%$
  - Let's discuss this (window size=112/112 – need to plan with power TSV's as well to get combined picture)

# IMAX CALCULATION

- 50mA/TSV  $\sim T=105^{\circ}\text{C}$
- $50\text{mA} * 2250 \text{ C4 for } V_{\text{cctop}} * 6 \text{ tsvs/C4} = 675\text{A } I_{\text{max}}$ .
- No issue with  $I_{\text{max}}$  😊



# OTHER TOPICS

- Thermal Coefficients to do thermal analysis.
- How many die can we stack in this way?
  - If base die contained memory, can we stack multiple base dies with a signal top die to increase memory capacity.

# SUMMARY

- Power delivery –TSV density well within the bounds for density and easily meets I<sub>max</sub> limits
  - But 112um by 112um window may mean some windows have no TSV's (foils mention no minimum so assume this is OK)
- Signal density seems to be an issue
  - At current n5 sizes for the HIP, TSV density will limit how tightly we can pack Hybrid Bond buffers
  - We exceeded 2% with signals only
  - How much of the 1% power overhead needs to be factored into the signal limit – requires further study of a full D2D Hybrid Bond pad plan including power Hybrid Bond pads.

# BACKUP



# PROPOSAL CARTOON

F2B – Base die – which implementation?

2x2 diameter

